•	Member of the Texas Instruments Widebus™ Family	DGG, DG	iv, or e (top vi		ACKAGE
•	High-Bandwidth Data Path (Up To 500 MHz [†])	NC [1A1 [- F] 1 <u>0E</u>] 20E
•	5-V Tolerant I/Os with Device Powered Up or Powered Down	1A2 [1A3 [3	54]1B1]1B2
•	Low and Flat ON-State Resistance (r_{on}) Characteristics Over Operating Range (r_{on} = 5 Ω Typical)	1A4 [1A5 [1A6 [5 6	52 51] 1B3] 1B4] 1B5
•	Rail-to-Rail Switching on Data I/O Ports – 0-V to 5-V Switching With 3.3-V V _{CC} – 0-V to 3.3-V Switching With 2.5-V V _{CC}	GND [1A7 [1A8 [8 9	49 48] GND] 1B6] 1B7
•	Bidirectional Data Flow, With Near-Zero Propagation Delay	1A9 1A10	12	45]1B8]1B9
•	Low Input/Output Capacitance Minimizes Loading and Signal Distortion (C _{io(OFF)} = 4 pF Typical)	1A11 L 1A12 [2A1 [14 15	43 42]1B10]1B11]1B12
•	Fast Switching Frequency (f _{OE} = 20 MHz Max)	2A2 [V _{CC} [2A3 [17	40] 2B1] 2B2] 2B3
•	Data and Control Inputs Provide Undershoot Clamp Diodes	GND [2A4 [19	38	GND 2B4
•	Low Power Consumption (I _{CC} = 1 mA Typical)	2A5 [2A6 [21		2B5 2B6
•	V _{CC} Operating Range From 2.3 V to 3.6 V Data I/Os Support 0-V to 5-V Signaling	2A7 [2A8 [24	33] 2B7] 2B8
	Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)	2A9 [2A10 [26	31	2B9 2B10
•	Control Inputs Can be Driven by TTL or 5-V/3.3-V CMOS Outputs	2A11 [2A12 []2B11]2B12

- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: PCI Interface, Differential Signal Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating
 - [†] For additional information regarding the performance characteristics of the CB3Q family, refer to the TI application report, *CBT-C, CB3T, and CB3Q Signal-Switch Families*, literature number SCDA008.



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NC – No internal connection

description/ordering information

The SN74CB3Q16211 is a high-bandwidth FET bus switch utilizing a charge pump to elevate the gate voltage of the pass transistor, providing a low and flat ON-state resistance (ron). The low and flat ON-state resistance allows for minimal propagation delay and supports rail-to-rail switching on the data input/output (I/O) ports. The device also features low data I/O capacitance to minimize capacitive loading and signal distortion on the data bus. Specifically designed to support high-bandwidth applications, the SN74CB3Q16211 provides an optimized interface solution ideally suited for broadband communications, networking, and data-intensive computing systems.

The SN74CB3Q16211 is organized as two 12-bit bus switches with separate output-enable (1OE, 2OE) inputs. It can be used as two 12-bit bus switches or as one 24-bit bus switch. When OE is low, the associated 12-bit bus switch is ON and the A port is connected to the B port, allowing bidirectional data flow between ports. When OE is high, the associated 12-bit bus switch is OFF, and a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry prevents damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

T _A	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
		Tube	SN74CB3Q16211DL	00000000
	SSOP – DL	Tape and reel	SN74CB3Q16211DLR	CB3Q16211
–40°C to 85°C	TSSOP – DGG	Tape and reel	SN74CB3Q16211DGGR	CB3Q16211
	TVSOP – DGV	Tape and reel	SN74CB3Q16211DGVR	BW211
	VFBGA – GQL	Tape and reel	SN74CB3Q16211GQLR	

ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

GQL PACKAGE (TOP VIEW)

		1	2	3	4	5	6	
A	$\left(\right)$	С	С	С	С	С	\bigcirc	
в		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
С		\bigcirc	С	С	\bigcirc	\bigcirc	С	
D		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
Е		\bigcirc	\bigcirc			\bigcirc	\bigcirc	
F		\bigcirc	\bigcirc			\bigcirc	\bigcirc	
G		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
н		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
J		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
к		\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
	~							/

terminal assignments

	1	2	3	4	5	6
Α	1A2	1A1	NC	1OE	2OE	1B1
в	1A5	1A4	1A3	1B2	1B3	1B4
С	1A7	GND	1A6	1B5	GND	1B6
D	1A10	1A8	1A9	1B8	1B7	1B9
Е	1A12	1A11			1B10	1B11
F	2A1	2A2			2B1	1B12
G	Vcc	GND	2A3	2B3	GND	2B2
Н	2A4	2A5	2A6	2B6	2B5	2B4
J	2A7	2A8	2A9	2B9	2B8	2B7
κ	2A10	2A11	2A12	2B12	2B11	2B10

NC - No internal connection



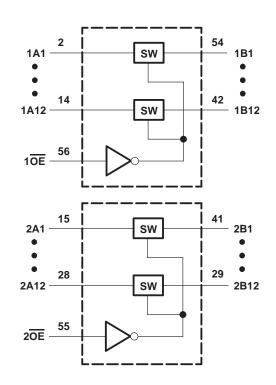
FUNCTION TABLE (each 12-bit bus switch) INPUT OE INPUT/OUTPUT A FUNCTION L B A port = B port

Disconnect

Ζ

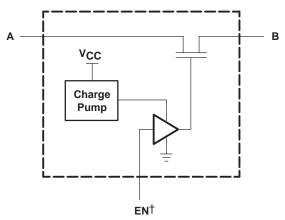
Н

logic diagram (positive logic)



Pin numbers shown are for the DGG, DGV, and DL packages.

simplified schematic, each FET switch (SW)



[†] EN is the internal enable signal applied to the switch.



SCDS167 - MAY 2004

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} (see Note 1) Control input voltage range, V _{IN} (see Notes 1 and 2) .	
Switch I/O voltage range, $V_{I/O}$ (see Notes 1, 2, and 3)	
Control input clamp current, I _{IK} (V _{IN} < 0)	
I/O port clamp current, I _{I/OK} (V _{I/O} < 0)	–50 mA
ON-state switch current, II/O (see Note 4)	±64 mA
Continuous current through V _{CC} or GND terminals	±100 mA
Package thermal impedance, θ_{JA} (see Note 5): DGG p	ackage 64°C/W
DGV p	ackage 48°C/W
DL pac	kage 56°C/W
GQL p	ackage 42°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to ground unless otherwise specified.

- 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- 3. VI and V_O are used to denote specific conditions for $V_{I/O}$.
- 4. II and IO are used to denote specific conditions for II/O.
- 5. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

			MIN	MAX	UNIT	
VCC	Supply voltage		2.3	3.6	V	
	LP-b. Level en etc. Preset en lle en	V_{CC} = 2.3 V to 2.7 V	1.7	5.5		
VIH	High-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$	2	5.5	V	
	Low lovel ended for dealth and	V_{CC} = 2.3 V to 2.7 V		0.7	V	
VIL	Low-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$	0	0.8	V	
V _{I/O}	Data input/output voltage		0	5.5	V	
TA	Operating free-air temperature		-40	85	°C	

NOTE 6: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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PA	RAMETER		TEST CONDITION	NS	MIN 1	гүр†	MAX	UNIT
VIK		V _{CC} = 3.6 V,	lj = -18 mA				-1.8	V
IIN	Control inputs	V _{CC} = 3.6 V,	V _{IN} = 0 to 5.5 V				±1	μΑ
IOZ‡	-	V _{CC} = 3.6 V,	$V_{O} = 0$ to 5.5 V, $V_{I} = 0$,	Switch OFF, $V_{IN} = V_{CC}$ or GND			±1	μΑ
loff		$V_{CC} = 0,$	$V_{O} = 0$ to 5.5 V,	V _I = 0			1	μΑ
ICC		V _{CC} = 3.6 V,	I _{I/O} = 0, Switch ON or OFF,	$V_{IN} = V_{CC}$ or GND		1	3	mA
∆ICC§	Control inputs	V _{CC} = 3.6 V,	One input at 3 V,	Other inputs at V _{CC} or GND			30	μΑ
ICCD	Per control input	V _{CC} = 3.6 V,	A and B ports open, Control input switchin	g at 50% duty cycle		0.15	0.25	mA/ MHz
C _{in}	Control inputs	V _{CC} = 3.3 V,	V _{IN} = 5.5 V, 3.3 V, or	0		3.5	5	pF
C _{io(OFI}	=)	V _{CC} = 3.3 V,	Switch OFF, V _{IN} = V _{CC} or GND,	V _{I/O} = 5.5 V, 3.3 V, or 0		4	5	pF
C _{io(ON)})	V _{CC} = 3.3 V,	Switch ON, V _{IN} = V _{CC} or GND,	V _{I/O} = 5.5 V, 3.3 V, or 0	10 12.		12.5	pF
		V _{CC} = 2.3 V,	$V_{\parallel} = 0,$	I _O = 30 mA		5	8	
r _{on} #		TYP at $V_{CC} = 2.5 V$	V _I = 1.7 V,	I _O = -15 mA		5	9	0
		Vac - 2 V	$V_{I} = 0,$	I _O = 30 mA		5	6.5	Ω
		VCC = 3 V	V _I = 2.4 V,	I _O = -15 mA		5	8	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

NOTE 7: VIN and IIN refer to control inputs. VI, VO, II, and IO refer to data pins.

[†] All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C.

[‡] For I/O ports, the parameter I_{OZ} includes the input leakage current.

§ This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

This parameter specifies the dynamic power-supply current associated with the operating frequency of a single control input (see Figure 2). # Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by

the lower of the voltages of the two (A or B) terminals.

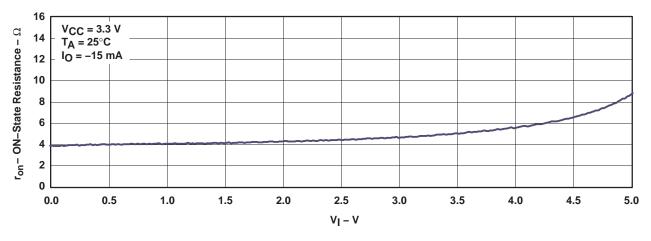
switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	TO	×CC = ± 0.2	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 3.3 V ± 0.3 V	
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	
fOE	OE	A or B		10		20	MHz
t _{pd} ☆	A or B	B or A		0.15		0.25	ns
ten	OE	A or B	1.5	8	1.5	8	ns
^t dis	OE	A or B	1	7.5	1	7.5	ns

|| Maximum switching frequency for control input (V_O > V_{CC}, V_I = 5 V, R_L \ge 1 MΩ, C_L = 0)

* The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).







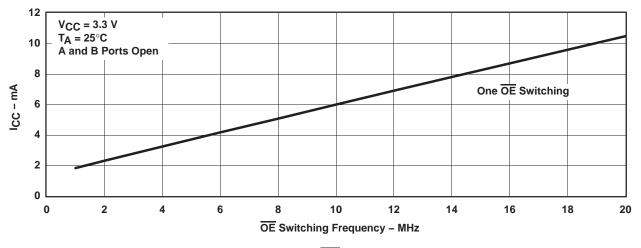
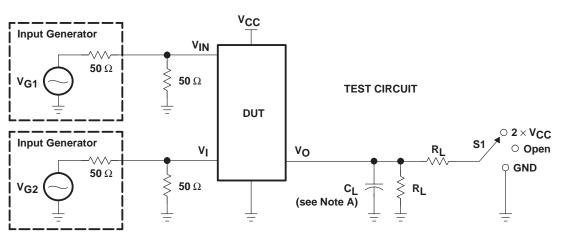


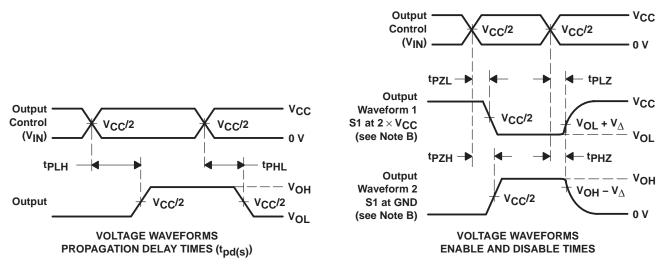
Figure 2. Typical I_{CC} vs $\overline{\text{OE}}$ Switching Frequency





PARAMETER MEASUREMENT INFORMATION

TEST	Vcc	S1	RL	٧I	CL	v_Δ
^t pd(s)	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	Open Open	500 Ω 500 Ω	V _{CC} or GND V _{CC} or GND	30 pF 50 pF	
^t PLZ ^{/t} PZL	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	$\begin{array}{c} 2 \times \mathbf{V}_{CC} \\ 2 \times \mathbf{V}_{CC} \end{array}$	500 Ω 500 Ω	GND GND	30 pF 50 pF	0.15 V 0.3 V
^t PHZ ^{/t} PZH	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	GND GND	500 Ω 500 Ω	V _{CC} V _{CC}	30 pF 50 pF	0.15 V 0.3 V

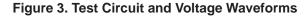


NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.

- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tpLH and tpHL are the same as tpd(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.







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3-Dec-2012

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)		Drawing			(2)		(3)	(Requires Login)
74CB3Q16211DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74CB3Q16211DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74CB3Q16211DGVRE4	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74CB3Q16211DGVRG4	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74CB3Q16211DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211DGVR	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74CB3Q16211GQLR	OBSOLETI	BGA MICROSTAR JUNIOR	GQL	56		TBD	Call TI	Call TI	
SN74CB3Q16211ZQLR	ACTIVE	BGA MICROSTAR JUNIOR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

PACKAGE OPTION ADDENDUM



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3-Dec-2012

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal			_		r							-
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74CB3Q16211DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74CB3Q16211DGVR	TVSOP	DGV	56	2000	330.0	24.4	6.8	11.7	1.6	12.0	24.0	Q1
SN74CB3Q16211DLR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
SN74CB3Q16211ZQLR	BGA MI CROSTA R JUNI OR	ZQL	56	1000	330.0	16.4	4.8	7.3	1.5	8.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

10-Oct-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74CB3Q16211DGGR	TSSOP	DGG	56	2000	367.0	367.0	45.0
SN74CB3Q16211DGVR	TVSOP	DGV	56	2000	367.0	367.0	45.0
SN74CB3Q16211DLR	SSOP	DL	56	1000	367.0	367.0	55.0
SN74CB3Q16211ZQLR	BGA MICROSTAR JUNIOR	ZQL	56	1000	333.2	345.9	28.6

ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is Pb-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).

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MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

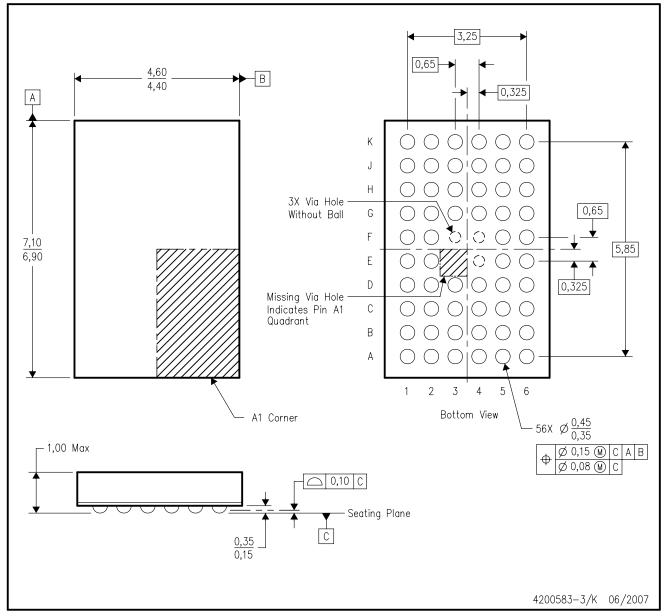
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



MECHANICAL DATA

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN

DL (R-PDSO-G**)



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118



MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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